

United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/766,125	01/28/2004	Jeffrey T. Fanton	TWI-14320	2124
28584	7590 10/05/2004		EXAM	INER
STALLMAN & POLLOCK LLP SUITE 2200			SONG, HOON K	
353 SACRAMENTO STREET			ART UNIT	PAPER NUMBER
SAN FRANCISCO, CA 94111			2882	

DATE MAILED: 10/05/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

			MI			
	Application No.	Applicant(s)				
	10/766,125	FANTON ET AL.				
Office Action Summary	Examiner	Art Unit				
	Hoon Song	2882				
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet	with the correspondence ad	dress			
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	6(a). In no event, however, may within the statutory minimum of ti ill apply and will expire SIX (6) Mo cause the application to become	a reply be timely filed hirty (30) days will be considered timel DNTHS from the mailing date of this c ABANDONED (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on	_•					
,—	☐ This action is FINAL. 2b) ☐ This action is non-final.					
3) Since this application is in condition for allowar	•		merits is			
closed in accordance with the practice under E	x parte Quayle, 1935 C	.D. 11, 453 O.G. 213.				
Disposition of Claims						
4) \boxtimes Claim(s) <u>1-7</u> is/are pending in the application.						
4a) Of the above claim(s) is/are withdray	4a) Of the above claim(s) is/are withdrawn from consideration.					
5)⊠ Claim(s) <u>1-4</u> is/are allowed.	☑ Claim(s) <u>1-4</u> is/are allowed.					
6)⊠ Claim(s) <u>5-7</u> is/are rejected.						
7) Claim(s) is/are objected to.						
8) Claim(s) are subject to restriction and/or	r election requirement.					
Application Papers						
9) The specification is objected to by the Examine						
10)⊠ The drawing(s) filed on <u>28 January 2004</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.						
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).						
11)☐ The oath or declaration is objected to by the Ex	aminer. Note the attach	ed Office Action or form P	ГО-152.			
Priority under 35 U.S.C. § 119						
 12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 	s have been received.					
3. Copies of the certified copies of the priority documents have been received in this National Stage						
application from the International Bureau	•					
* See the attached detailed Office action for a list of the certified copies not received.						
Attachment(s)	_					
1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948)		v Summary (PTO-413) o(s)/Mail Date				
 2) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) 	5) 🔲 Notice o	f Informal Patent Application (PT	O-152)			
Paper No(s)/Mail Date <u>1/28/04</u> .	•					

DETAILED ACTION

Claim Objections

Claims 5-7 are objected to because of the following informalities:

Regarding claim 5 line 2 and 7, "capable of" is vague.

Regarding claim 6 line 2, "capable of" is vague.

Regarding claim 7 line 2, "capable of " is vague.

Appropriate correction is required.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless --

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 5-6 are rejected under 35 U.S.C. 102(b) as being anticipated by Nikoonahad et al. (US 6215551B1).

Regarding claims 5-6, Nikoonahad teaches a system for inspecting a sample, comprising:

a probe beam source capable of focusing a probe beam spot on the sample surface, said probe beam spot having a generally elliptical shape with a long and a short axis (figure 1a); and

a movable stage (124) for supporting the sample and adjusting the position of the sample with respect to the probe beam, the moveable stage being capable of both rotational and linear movement (column 12 line 52-60), the moveable stage capable of

Application/Control Number: 10/766,125 Page 3

Art Unit: 2882

positioning the sample with respect to the probe beam. (Note: a recitation of the intended use of the claimed invention must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art. If the prior art structure is capable of performing the intended use, then it meets the claim. In a claim drawn to a process of making, the intended use must result in a manipulative difference as compared to the prior art. See *In re Casey*, 152 USPQ 235 (CCPA 1967) and *In re Otto*, 136 USPQ 458, 459 (CCPA 1963). In this case, "when an inspection spot is determined to be close to the edge of the sample, the probe beam spot falls on the inspection spot with the short axis being substantially perpendicular to the sample edge, the positioning of the sample including rotating the sample with respect to the probe beam in order to minimize an area of the sample which cannot be accurately inspected" is intended use since Nikoonahad's rotatable wafer stage is capable of performing the claimed invention.)

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claim 7 is rejected under 35 U.S.C. 103(a) as being unpatentable over Nikoonahad in view of Piwonka-Corle et al. (US 6734967).

Regarding claim 7, Nikoonahad fails to teach the probe beam source includes a rotating optics head capable of adjusting the shape of the beam spot on the sample surface.

Piwonka-Corle teaches a rotating optics for adjusting a shape of a beam spot.

It would have been obvious to one of ordinary skill in the art at the time of the invention to adapt the inspection system of Nikoonahad with the rotating optics as taught by Piwonka-Corle, since the rotating optics of Piwonka-Corle would provide the flexibility to adjust inspection focal spot.

Allowable Subject Matter

Claims 1-4 are allowed over prior art.

The following is a statement of reasons for the indication of allowable subject matter:

Regarding claim 1, none of the prior art teaches a method for inspecting a sample with a elliptical shaped probe beam by determining a proximity of an inspection spot on the sample surface to an edge of the sample and positioning the sample with respect to the probe beam so that probe beam spot falls on the inspection spot with a short axis of the elliptical spot being substantially perpendicular to the sample edge as claimed in independent claim 1.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Hoon Song whose telephone number is (571) 272-2494. The examiner can normally be reached on 8:30 AM - 5 PM, Monday - Friday.

Application/Control Number: 10/766,125 Page 5

Art Unit: 2882

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Edward Glick can be reached on (571) 272 - 2490. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

HKS 9/30/04

SUPERVISORY PATENT EXAMINES